

SiPM and scintillator characterization for highly granular calorimeters

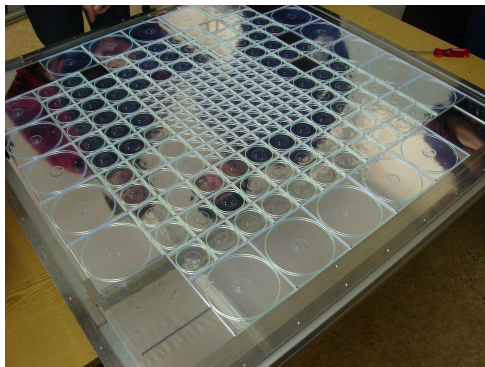
Laszlo Varga (CERN, Eotvos Lorand University HU)

December 10- 11, 2015
CALICE AHCAL Main Meeting



Motivation

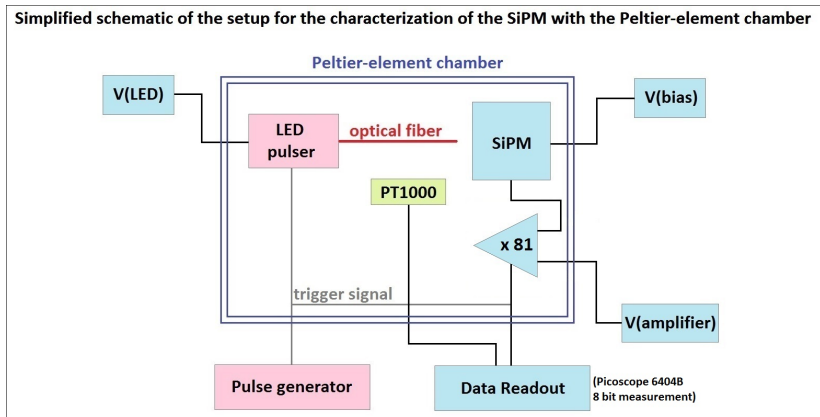
- Improve understanding of scintillators and SiPMs and related systematic effects in HCAL and ECAL applications
- Characterize impact of scintillator wrappings and tile size on measured light yield



Sensitive layer of the CALICE AHCAL

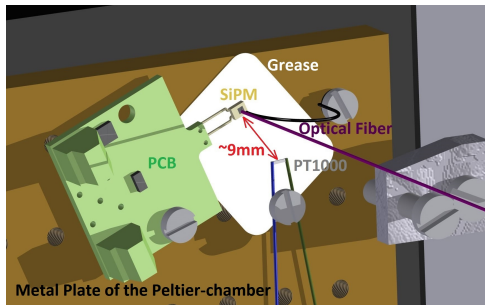
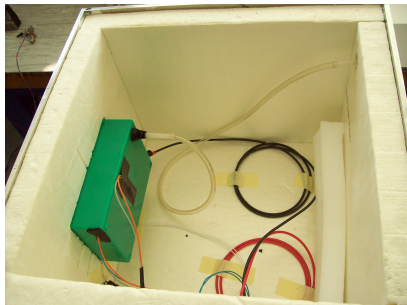
Calibration of the SiPM: Gain vs. Temperature

Schematic of the Gain vs. Temperature measurement



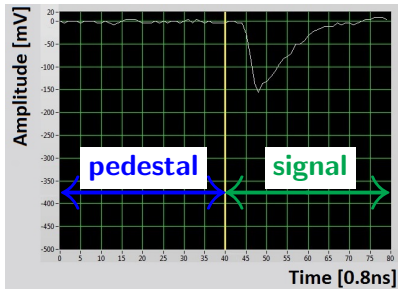
- Optical fiber in front of the SiPM connected to an LED pulser
- Measure SiPM signal from individual photons for gain calibration
- Temperature regulation is done by a thermally isolated Peltier-element chamber with temperature range covering well region of interest [15°C - 30°C]

The interior of the Peltier-element chamber



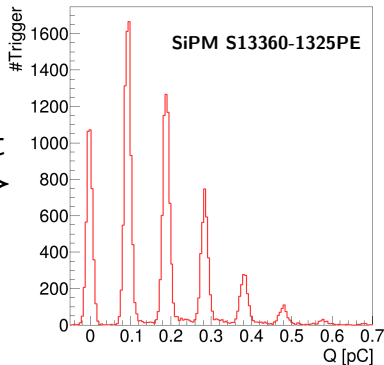
- The temperature of the metal plate inside is adjustable
- Ensure good heat flow between metal plate, SiPM and thermometer (PT1000) by using thermally conductive grease
- The temperature of the SiPM is measured with the PT1000 thermometer
- Temperature of metal plate is measured directly on metal plate

The method of the charge measurement



$$\int dt$$


Signal-Pedestal

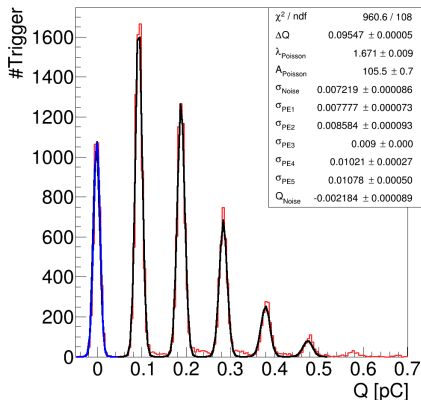


- Two time windows for pedestal and signal measurement
- Convert signal and pedestal response to charge by time integration
- Subtract pedestal from signal event-by-event

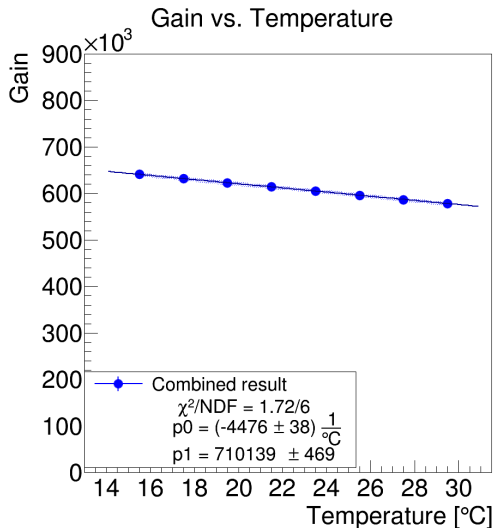
The fitting procedure

- Measure the charge of single photons
- Measure T simultaneously
- Fit as many peaks as possible using separate Gaussian functions with correlated parameters:

$$A_{\text{Pois}} \cdot \text{Poisson}(n_{\text{peak}}; \lambda) \cdot \text{Gauss}(x; Q_{\text{PE1}} + i \cdot d; \sigma_i)$$
- d = distance between the peaks
 \Rightarrow Gain (=G)
- Repeat the method for every T value
 \Rightarrow G – T dependence



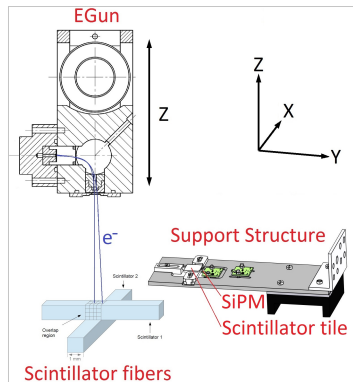
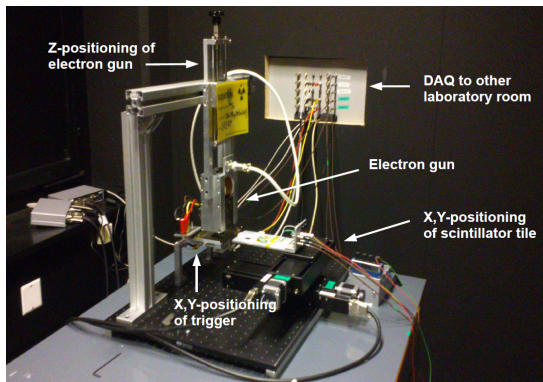
G - T calibration results



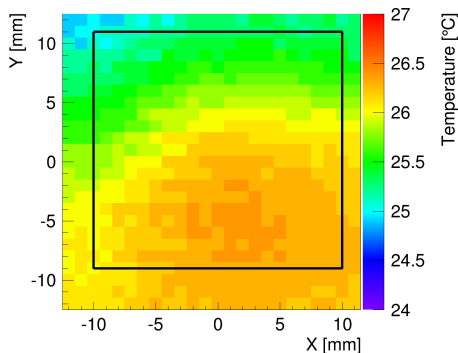
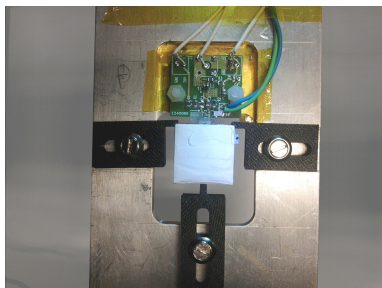
- Scanned a temperature range [15.5°C- 29.5°C] two times (↑ and ↓) with 2°C steps
- Combine the ↑ and ↓ measurements
- Fit G - T with linear function:
 $G(T) = p_0 \cdot T + p_1$
 $\Rightarrow 0.76 \left[\frac{\%}{^\circ\text{C}} \right]$ dependency
- Stable results within < 1% when changing N_{bins} , N_{peaks} , LED settings

Results of the scintillator tile scans

The experimental layout for tile-measurements at CERN



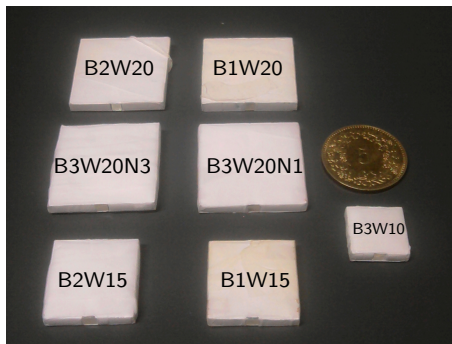
Immediate environment of the scintillator tile



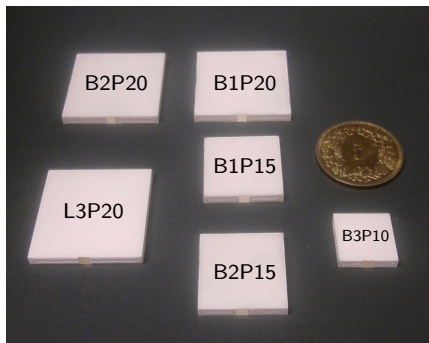
- Use tile support structure with low material close to the tile to avoid signal from stray electrons in the support structure in the tile
- 1 mm step size, 100 s measurement time for each step
- Temperature variation during the measurement $\sim 2^\circ\text{C}$
 - ⇒ influence on the SiPM gain $\sim 1.5\%$
 - ⇒ correct the temperature to $T_{\text{ref}} = 25^\circ\text{C}$

Scanned tile set

Wrapped tiles



Painted tiles



- coating:
 - ⇒ wrapping (3M foil)
 - ⇒ reflective paint

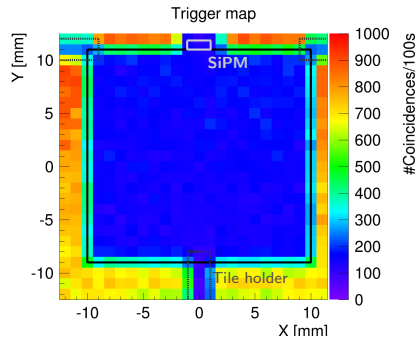
- size:
 - ⇒ $\square 20 \times 2 \text{ mm}^3$
 - ⇒ $\square 15 \times 2 \text{ mm}^3$
 - ⇒ $\square 10 \times 2 \text{ mm}^3$

Regions of a tile scan

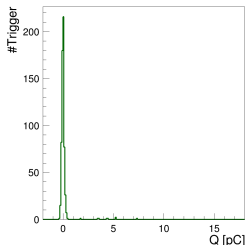
e^- beam is $\sim 1\text{mm}^2$

\Rightarrow 3 regions depending on the beam position:

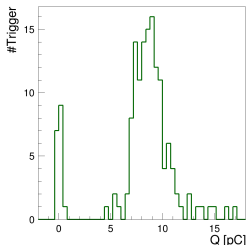
- e^- beam outside of the tile
- e^- beam on the tile edge
- e^- beam inside of the tile



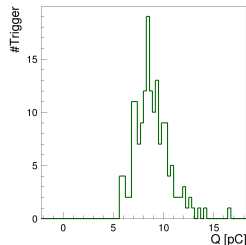
Outside the tile



Edge of the tile



Inside the tile



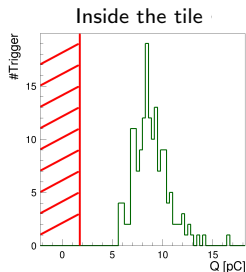
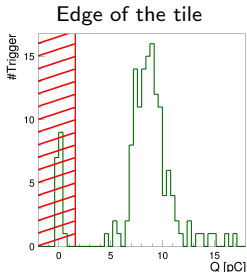
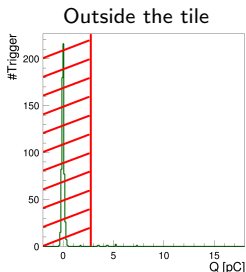
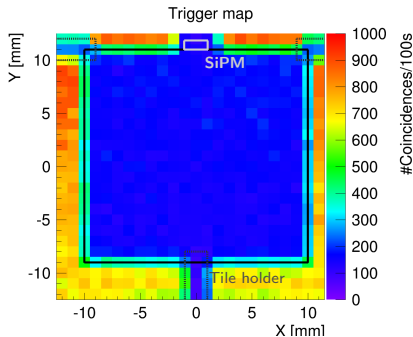
Regions of a tile scan

e^- beam is $\sim 1\text{mm}^2$

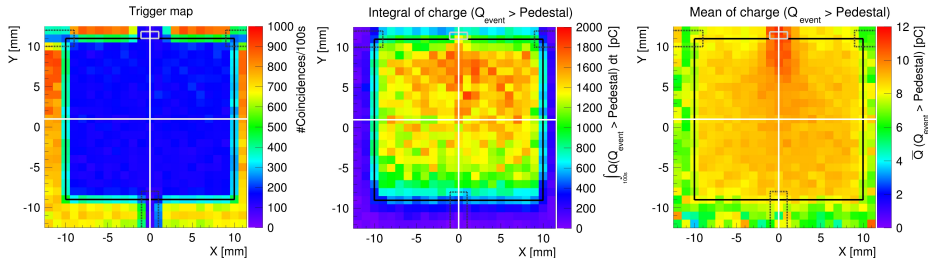
\Rightarrow 3 regions depending on the beam position:

- e^- beam outside of the tile
- e^- beam on the tile edge
- e^- beam inside of the tile

Remove events with charge similar to $Q_{\text{ped. subwindow}}$

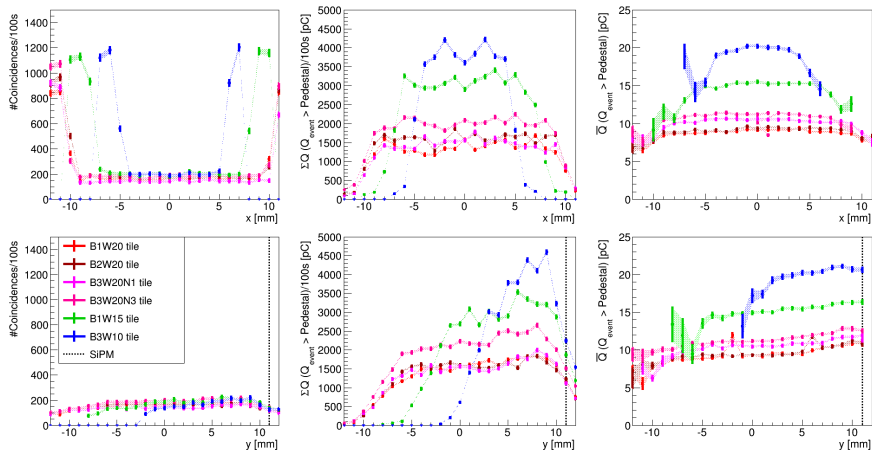


Evaluation of the tile scans



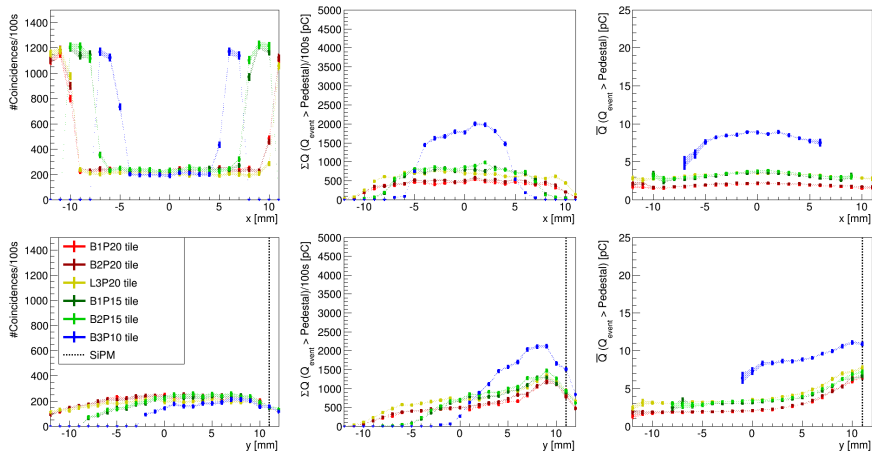
- 3 types of map from the scanned area:
 - ⇒ Trigger map: verify position of the tile edges
 - ⇒ Integral of the charge map: Investigate the edge effects and the uniformity
 - ⇒ Mean of the charge map: Compare the light yield of the tiles
- Study observables for two slices in x and y direction

Slices of all wrapped tiles

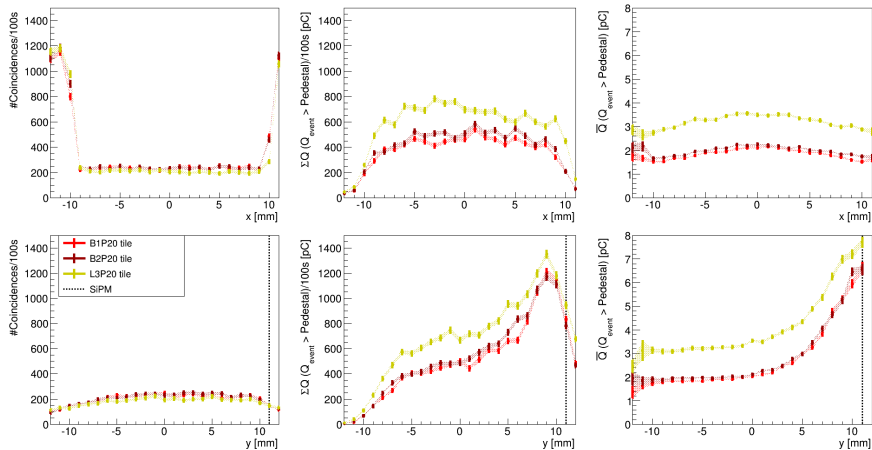


- The light yield scales with the sizes of the tile (\sim SiPM area to tile front area)
- The light yields of the wrapped tiles of same size differ to each other by 20%

Slices of all painted tiles



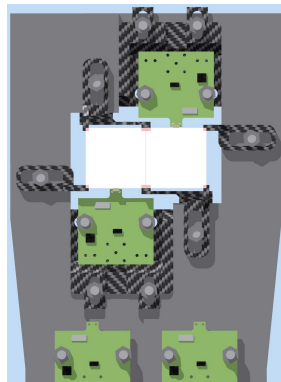
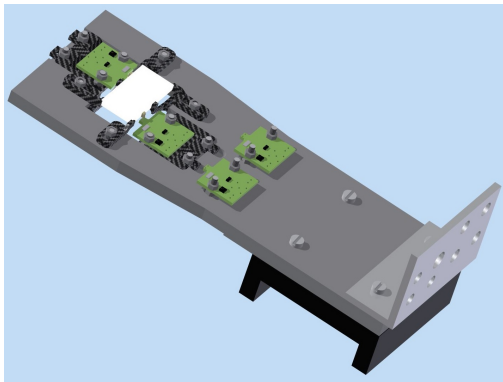
- The light yield of the painted tiles is $\sim 4-5$ times lower than for wrapped tiles
- The light yield is more similar for painted tiles of same size (within 7%) than for wrapped tiles (20%)

Slices of $20 \times 20 \text{ mm}^2$ painted tiles

- The light yield of the painted tiles can be increased by using thicker painting:
 - ⇒ 2 layers of painting
 - ⇒ 3 layers of painting (50% more light yield)

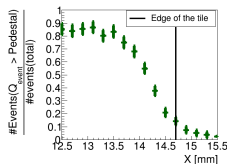
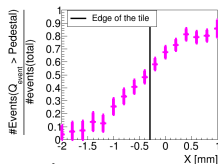
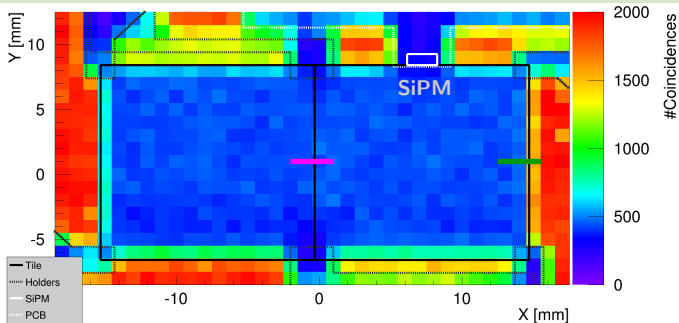
2 tile setup

Layout of the 2 tile measurement



- Multi-tile setup for investigation of edge effects
- Setup allows for investigation of different tile sizes ($20 \times 20 \text{ mm}^2$, $15 \times 15 \text{ mm}^2$, $10 \times 10 \text{ mm}^2$)

First results



- One SiPM is used for readout
- On the trigger map the position of the tiles, the holders, the SiPM are visible
- Higher ratio of events above pedestal at the common edge can come from light leakage or stray e^- in the neighboring scintillator tile

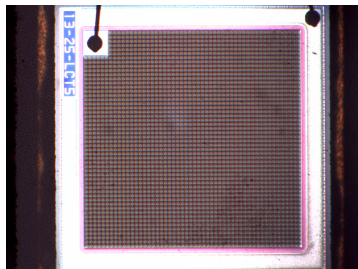
Summary and Outlook

- Gain-temperature calibration
 - ⇒ Controlled temperature with Peltier-element chamber [15.5°C- 29.5°C]
 - ⇒ Ensured good heat flow between all components using thermal grease
 - ⇒ Calibrated gain as a function of temperature and studied systematic uncertainties
- Tile scans
 - ⇒ The light yield of the wrapped tile is $\sim 4-5$ times higher than for the painted tile independent of the size
 - ⇒ The light yield scales with the sizes of the tile (\sim SiPM area to tile front area)
 - ⇒ The light yield is more similar for painted tiles of same size (within 7%) than for wrapped tiles (20%)
 - ⇒ The light yield of the wrapped tiles is more homogeneous than the painted tiles
 - ⇒ The light yield of the painted tiles can be increased using thicker painting
 - ⇒ 2 tile setup: Higher ratio of events above pedestal at the common edge
- Outlook
 - ⇒ Connection between T dependence of gain and tile scan measurements
 - ⇒ Further investigations with the multi-tile setup with 2 or 4 tiles of different sizes
 - ⇒ Comparison of different SiPMs (pitch, type)

Thank you for your attention!

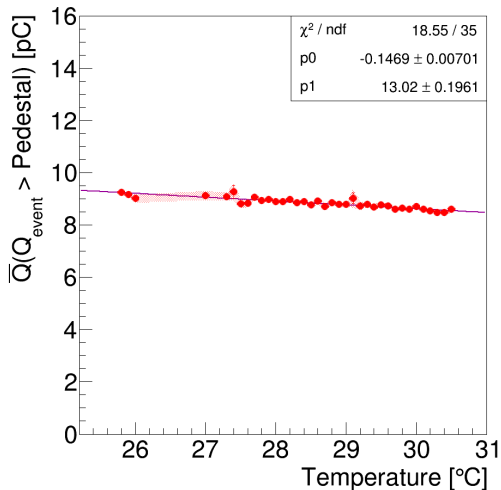
Reminder: The SiPM

- Silicon Photomultipliers (SiPMs) are photon sensitive devices built from an avalanche photodiode array on common Si substrate
 - The gain (G) of a SiPM depends on the temperature (T)
 - For a correct signal reconstruction, the temperature dependence needs to be known → Gain-Temperature calibration
 - Gain can be estimated using well-defined signal from single photons
-
- Hamamatsu MPPC:
 - 1.3x1.3 mm² effective photonsensitive area
 - 2668 pixels, 25 μm pixel size
 - Type No.: S13360-1325PE
 - Serial No.: 10036



Q - T calibration results

Mean of charge vs. Temperature



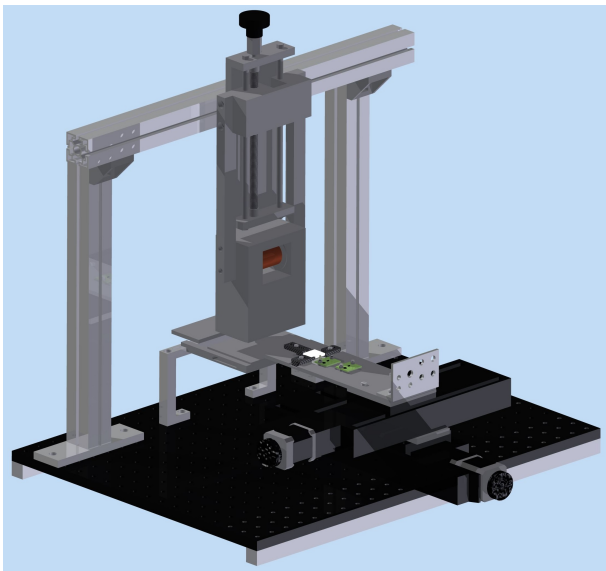
- Measure over long period in central region of tile
- Combine the data of same temperature
- Fit the dataset with linear function:

$$Q(T) = p_0 \cdot T + p_1$$

$$\Rightarrow 1.57 \left[\frac{\%}{^\circ\text{C}} \right] \text{ dependency}$$
- Reminder: for the G - T

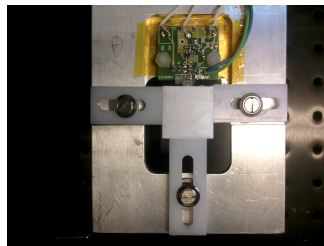
$$\Rightarrow 0.76 \left[\frac{\%}{^\circ\text{C}} \right] \text{ dependency}$$
- Stable results within $< 1\%$

Rendered setup at September 2015

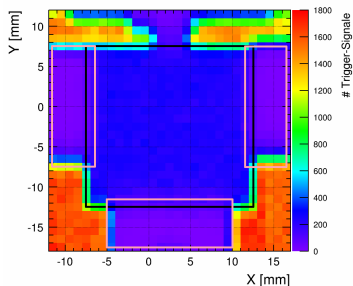


Setup at November 2014

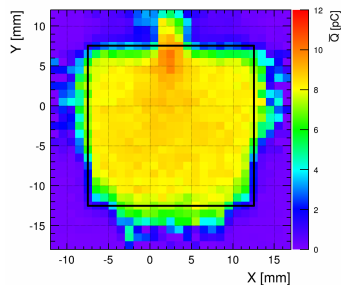
- At the beginning:
use "high-material" tile holders to hold the scintillator in place
- The #Trigger map shows the transparency of the support structure
- Even if the electron beam does not hit the scintillator, stray particles produced in the tile holders leak into scintillator resulting in a measurable signal



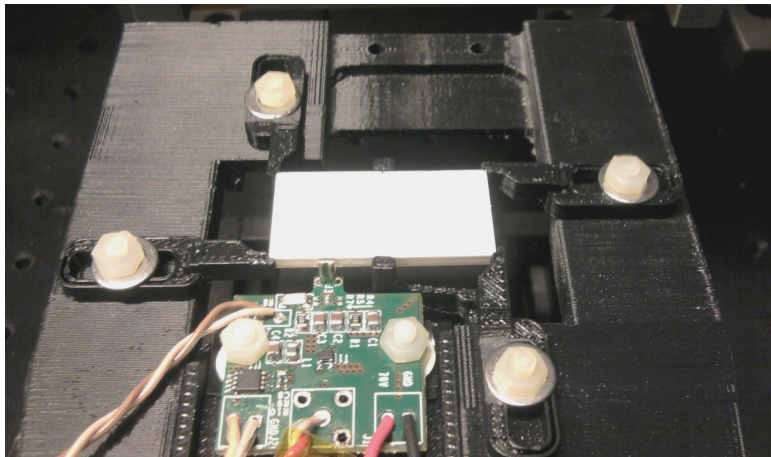
#Trigger map of a tilescan



\bar{Q} map of a scintillator tile



2 tile setup



Inside of the Peltier-element chamber

